


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552029	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  QIUWEN MI	<b>Art Unit</b>  1655

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
west, stn	6/4/08	QM
inventor name search, palm	6/4/08	QM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner